



P-Channel 1.5-V (G-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|---------------------|--------------------------------------|---------------------------------|-----------------------|--|--|--|
| V _{DS} (V) | $R_{DS(on)}\left(\Omega\right)$ | I _D (A) ^e | Q _g (Typ.) | | | |
| - 8 | 0.036 at V _{GS} = - 4.5 V | - 6 | | | | |
| | 0.045 at $V_{GS} = -2.5 \text{ V}$ | - 6 | 14 nC | | | |
| | 0.056 at V _{GS} = - 1.8 V | - 6 | 14 110 | | | |
| | 0.077 at V _{GS} = - 1.5 V | - 6 | | | | |

1206-8 ChipFET® Marking Code BP XXX Lot Traceability and Date Code Bottom View

Ordering Information: Si5499DC-T1-E3 (Lead (Pb)-free) Si5499DC-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

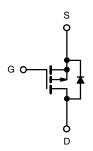
- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET[®] Power MOSFET: 1.5 V Rated
- Ultra-Low On-Resistance

Pb-free

ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

- Load Switch for Portable Devices
 - Guaranteed Operation at V_{GS} = 1.5 V Critical for Optimized Design and Longer Battery Life



P-Channel MOSFET

| Parameter | Symbol | Limit | Unit | |
|--|-----------------------------------|-----------------|------------------------|-----|
| Drain-Source Voltage | V _{DS} | - 8 | V | |
| Gate-Source Voltage | V _{GS} | ± 5 | v | |
| | T _C = 25 °C | | - 6 ^e | |
| Outiling Davis Output (T., 450,00)8 h | T _C = 70 °C | , | - 6 ^e | |
| Continuous Drain Current (T _J = 150 °C) ^{a, b} | T _A = 25 °C | I _D | - 6 ^{a, b, e} | |
| | T _A = 70 °C | | - 5.6 ^{a, b} | Α |
| Pulsed Drain Current (10 µs Pulse Width) | | I _{DM} | - 25 | |
| - · · · · · · · · · · · · · · · · · · · | T _C = 25 °C | | - 5.2 | |
| Continuous Source-Drain Diode Current ^{a, b} | T _A = 25 °C | l _s | - 2.1 ^{a, b} | |
| | T _C = 25 °C | | 6.2 | |
| Maximum Power Dissipation ^{a, b} | T _C = 70 °C | В | 4 | 147 |
| | T _A = 25 °C | P _D | 2.5 ^{a, b} | - w |
| | T _A = 70 °C | | 1.6 ^{a, b} | |
| Operating Junction and Storage Temperature Ran | T _J , T _{stg} | - 55 to 150 | 00 | |
| Soldering Recommendations (Peak Temperature) ^{c, d} | | | 260 | °C |

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. t = 5 s
- c. See Solder Profile (www.vishay.com/doc?73257). The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- e. Package limited.



| THERMAL RESISTANCE RATINGS | | | | | | | |
|---|--------------|-------------------|---------|---------|------|--|--|
| Parameter | | Symbol | Typical | Maximum | Unit | | |
| Maximum Junction-to-Ambient ^{a, b} | t ≤ 5 s | R _{thJA} | 48 | 50 | °C/W | | |
| Maximum Junction-to-Foot (Drain) | Steady State | R _{thJF} | 17 | 20 | C/VV | | |

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. Maximum under Steady State conditions is 95 $^{\circ}\text{C/W}.$

| SPECIFICATIONS T _J = 25 °C, unless otherwise noted | | | | | | | | |
|--|--|--|---|-------|-------|---------|--|--|
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | | |
| Static | | | | • | | • | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$ | - 8 | | | V | | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = - 250 μA | | 6 | | mV/°C | | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | 10 = - 250 μΑ | | 2.3 | | IIIV/ C | | |
| Cata Carrea Threahald Valtage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ | - 0.35 | | - 0.8 | V | | |
| Gate-Source Threshold Voltage | | $V_{DS} = V_{GS}$, $I_D = -5 \text{ mA}$ | $V_{DS} = V_{GS}, I_{D} = -5 \text{ mA}$ - 0.55 | | | V | | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$ | | | ± 100 | nA | | |
| Zara Cata Valtaga Drain Current | l | V _{DS} = - 8 V, V _{GS} = 0 V | | | - 1 | μΑ | | |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = -8 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$ | | | - 10 | | | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \le 5 \text{ V}, V_{GS} = -4.5 \text{ V}$ | - 25 | | | Α | | |
| | | V _{GS} = - 4.5 V, I _D = - 5.1 A | | 0.030 | 0.036 | | | |
| | D | V _{GS} = - 2.5 V, I _D = - 4.6 A | | 0.037 | 0.045 | | | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = - 1.8 V, I _D = - 4.3 A | | 0.046 | 0.056 | Ω | | |
| | | V _{GS} = - 1.5 V, I _D = - 1.3 A | | 0.057 | 0.077 | | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = - 4 V, I _D = - 5.1 A | | 18 | | S | | |
| Dynamic ^b | | | | • | | • | | |
| Input Capacitance | C _{iss} | | | 1290 | | | | |
| Output Capacitance | C _{oss} | $V_{DS} = -4 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | 420 | | pF | | |
| Reverse Transfer Capacitance | C _{rss} | | | 270 | | | | |
| Total Gate Charge | Q _g Q _{gs} Q _{gd} | V _{DS} = - 4 V, V _{GS} = - 8 V, I _D = - 6 A | | 23 | 35 | nC | | |
| Total Gate Charge | | | | 14 | 21 | | | |
| Gate-Source Charge | | $V_{DS} = -4 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -6 \text{ A}$ | | 1.7 | | | | |
| Gate-Drain Charge | | | | 2.7 | | | | |
| Gate Resistance | R_g | f = 1 MHz | | 8 | | Ω | | |
| Turn-On Delay Time | t _{d(on)} | | | 10 | 15 | | | |
| Rise Time | t _r | V_{DD} = - 4 V, R_L = 0.7 Ω | | 70 | 110 | | | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong$ - 5.6 A, V_{GEN} = - 4.5 V, R_g = 1 Ω | | 60 | 90 | ns | | |
| Fall Time | t _f | | | 30 | 45 | | | |
| Turn-On Delay Time | t _{d(on)} | | | 8 | 15 | 115 | | |
| Rise Time | t _r | V_{DD} = - 4 V, R_L = 0.7 Ω | | 70 | 110 | - | | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong$ - 5.6 A, V_{GEN} = - 8 V, R_g = 1 Ω | | 55 | 85 | | | |
| Fall Time | t _f | | | 55 | 85 | | | |





| SPECIFICATIONS $T_J = 25$ °C, unless otherwise noted | | | | | | | | |
|---|-----------------|---|------|-------|-------|------|--|--|
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | | |
| Drain-Source Body Diode Characteristics | | | | | | | | |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | - 6 | Α | | |
| Pulse Diode Forward Current | I _{SM} | | | | - 25 | A | | |
| Body Diode Voltage | V_{SD} | $I_S = -2.1 \text{ A}, V_{GS} = 0 \text{ V}$ | | - 0.7 | - 1.2 | V | | |
| Body Diode Reverse Recovery Time | t _{rr} | | | 45 | 70 | ns | | |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = - 5.6 A, dl/dt = 100 A/μs, T _{.I} = 25 °C | | 18 | 27 | nC | | |
| Reverse Recovery Fall Time | t _a | 1 - 3.0 Α, απαι - 100 Απμ3, 1 - 23 Ο | | 18 | | ns | | |
| Reverse Recovery Rise Time | t _b | | | 17 | | 115 | | |

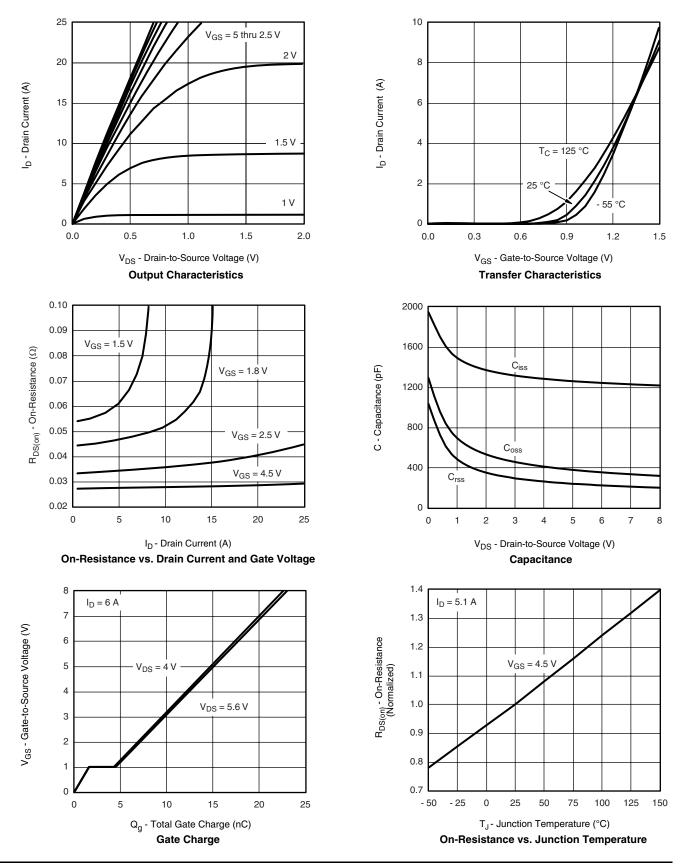
Notes:

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

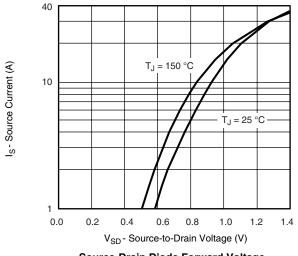


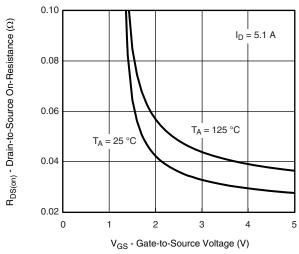




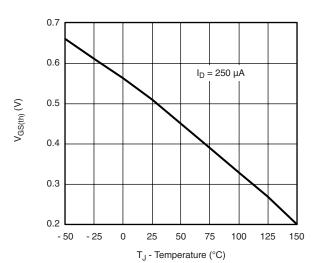


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



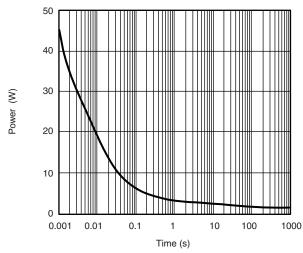


Source-Drain Diode Forward Voltage

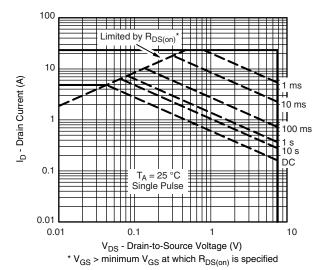


Threshold Voltage

On-Resistance vs. Gate-to-Source Voltage



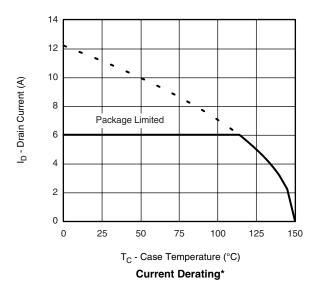
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

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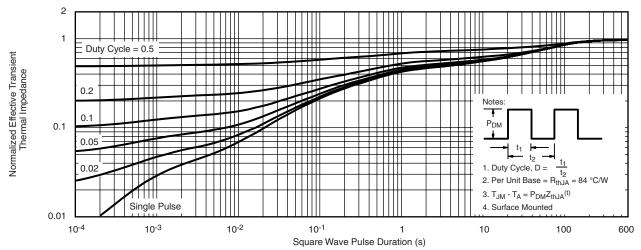
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



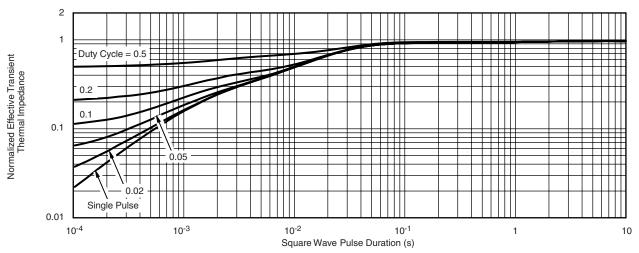
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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